Docket No.: 128503

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the Application of

Isao YOKOKAWA

Application No.: 10/584,771

Filed: June 28, 2006

For: METHOD FOR MEASURING AN AMOUNT OF STRAIN OF A BONDED STRAINED

WAFER

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

Pursuant to 37 CFR §1.56, the attention of the Patent and Trademark Office is hereby directed to the reference(s) listed on the attached PTO-1449. Unless otherwise indicated herein, one copy of each reference is attached. It is respectfully requested that the information be expressly considered during the prosecution of this application, and that the reference(s) be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

- 1. This Information Disclosure Statement is being filed (a) within three months of the U.S. filing date of this non-CPA application, OR (b) before the mailing date of a first Office Action on the merits in the present application. No certification or fee is required.
- 2. One or more reference cited herein was cited in a counterpart foreign application. A copy of the foreign search report is attached for the Examiner's information. See References 1 and 2.
- 3. In accordance with 37 CFR §1.98(a)(2)(ii), copies of any U.S. patents and patent application publications are not attached.
- 4. An English language Abstract of one or more non-English language reference is attached hereto. See Reference 2.

Respectfully submitted,

ans___

William P. Berridge Registration No. 30,024

Randi B. Isaacs Registration No. 56,046

WPB:RBI/aha

Date: January 24, 2007 OLIFF & BERRIDGE, PLC P.O. Box 19928 Alexandria, Virginia 22320 Telephone: (703) 836-6400 DEPOSIT ACCOUNT USE
AUTHORIZATION
Please grant any extension
necessary for entry;
Charge any fee due to our
Deposit Account No. 15-0461

Sheet 1	of	1
---------	----	---

Form PTO-1449 US Dept. of Comm (REV. 1/06) PATENT & TRADEMARK OFF		nmerce OFFICE	ATTY I 128503	DOCKET NO.		APPLICATION NO. 10/584,771				
INFORMATION DISCLOSURE STATEMENT										
(Use several sheets if necessary)			APPLICANT(S) Isao YOKOKAWA							
			FILING DATE June 28, 2006							
	U.S. PATENT DOCUMENTS									
Examiner Initials	Cite No.	Cite		te Name						
	1	5,414,747	05/09/1995		Ruud et al.					
							•			
										
FOREIGN PATENT DOCUMENTS										
Examiner Initials	Cite No.	Document Number	Da	ite	Country		With English Abstract	With English Translation		
	2	JP A 01-276052	11/06/1989		JAPAN		х			
			OTHER D	OCUME	NTS					
Examiner Initials	Cite No.									
					•					

<u>-</u> .										
				·						
						·				
						<u> </u>				
EXAMINER						DATE CO	ONSIDERED			
Examiner:	Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.									

Date: January 24, 2007